



X-838 US  
09/825,224

PATENT  
Conf. No. 9827

IN THE UNITED STATES PATENT OFFICE

Applicant: Alireza S. Kaviani  
Assignee: Xilinx, Inc.  
Title: Structure for Reducing Leakage Current in  
Submicron IC Devices  
Serial No.: 09/825,224 File Date: 4/2/2001  
Examiner: Kevin V. Quinto Art Unit: 2826  
Docket No.: X-838 US Conf. No.: 9827

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Mail Stop NON-FEE AMENDMENT  
COMMISSIONER FOR PATENTS  
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PRELIMINARY AMENDMENT

Before taking action in the above-referenced application,  
please enter the following amendments.